

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/623,934	TAKAHASHI, NAOMASA	
Examiner	Art Unit	
TuyetLien (Lien) T. Tran	2179	

SEARCHED						
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Attached updated EAST search history	1/31/2008	п			
consulted with Ba Huynh, AU 2179	1/31/2008	тт			
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